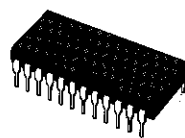


ANALOG MULTIPLEXER/DEMULTIPLEXER

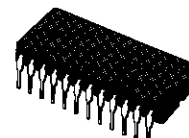
4067B-SINGLE 16-CHANNEL

4097B-DIFFERENTIAL 8-CHANNEL

- LOW ON RESISTANCE: 125Ω (typ.) OVER 15 Vp-p SIGNAL INPUT RANGE FOR $V_{DD} - V_{SS} = 15V$
- HIGH OFF RESISTANCE: CHANNEL LEAKAGE OF $\pm 10pA$ (typ.) @ $V_{DD} - V_{SS} = 10V$
- MATCHED SWITCH CHARACTERISTICS: $\Delta R_{ON} = 5\Omega$ (typ.) FOR $V_{DD} - V_{SS} = 15V$
- VERY LOW QUIESCENT POWER DISSIPATION UNDER A DIGITAL CONTROL INPUT AND SUPPLY CONDITIONS: 0.2μW (typ.) @ $V_{DD} - V_{SS} = 10V$
- BINARY ADDRESS DECODING ON CHIP
- QUIESCENT CURRENT SPECIFIED TO 20V FOR HCC DEVICE
- STANDARDIZED SYMMETRICAL OUTPUT CHARACTERISTICS
- 5V, 10V AND 15V PARAMETRIC RATINGS
- INPUT CURRENT OF 100nA AT 18V AND 25°C FOR HCC DEVICE
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC TENTATIVE STANDARD No 13A, "STANDARD SPECIFICATIONS FOR DESCRIPTION OF B-SERIE CMOS DEVICES"



EY
(Plastic Package)



F
(Ceramic Package)



M1
(Micro Package)

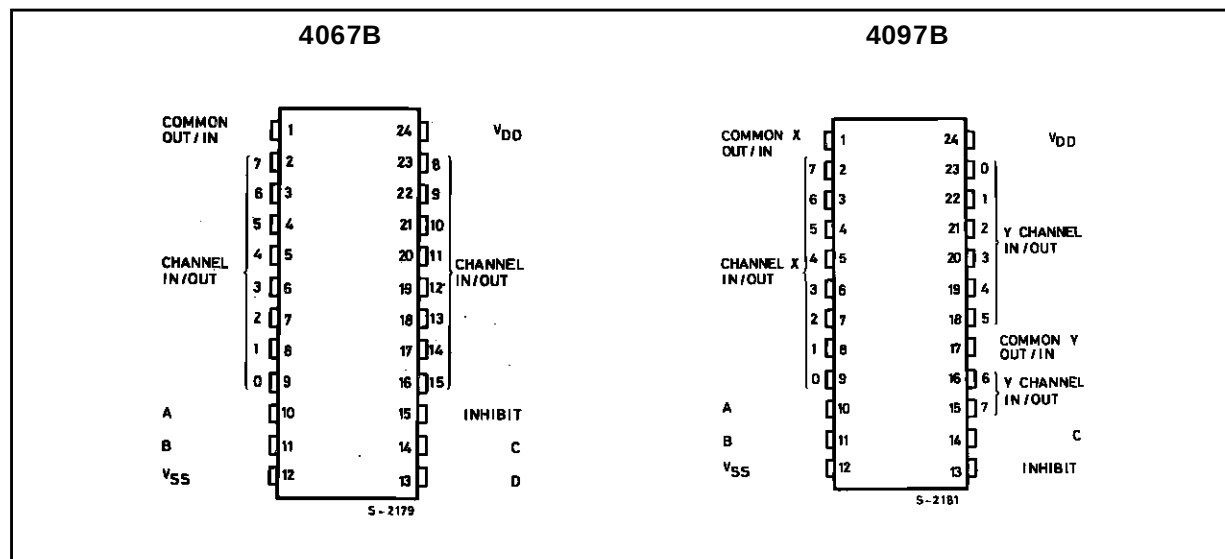


C1
(Chip Carrier)

ORDER CODES :

HCC40XXBF	HCF40XXBM1
HCF40XXBEY	HCF40XXBC1

PIN CONNECTIONS



DESCRIPTION

The **HCC4067B**, **HCC4097B** (extended temperature range) and **HCF4067B**, **HCF4097B** (intermediate temperature range) are monolithic integrated circuits available in 24-lead dual in line plastic or ceramic package.

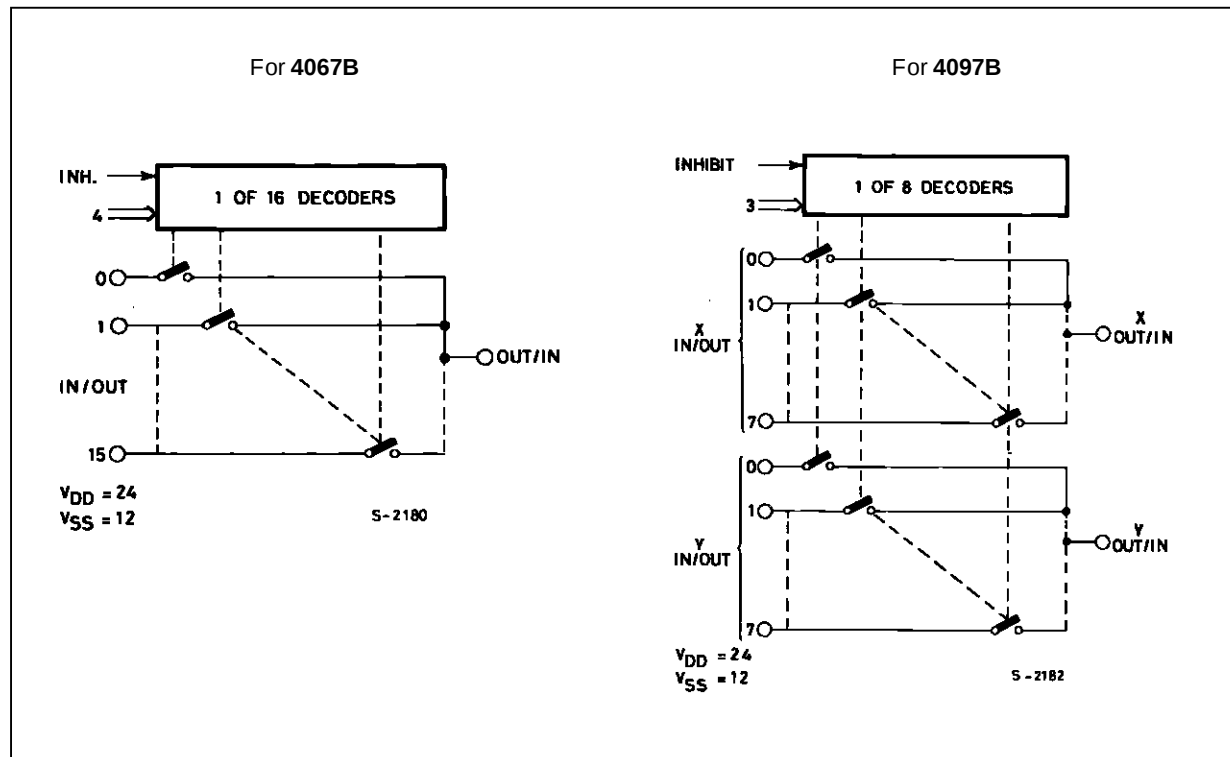
The **HCC/HCF4067B** and **HCC/HCF4097B** COS/MOS analog multiplexers/demultiplexers are digitally controlled analog switches having low ON impedance, low OFF leakage current and internal

address decoding. in addition, the ON resistance is relatively constant over the full input-signal range.

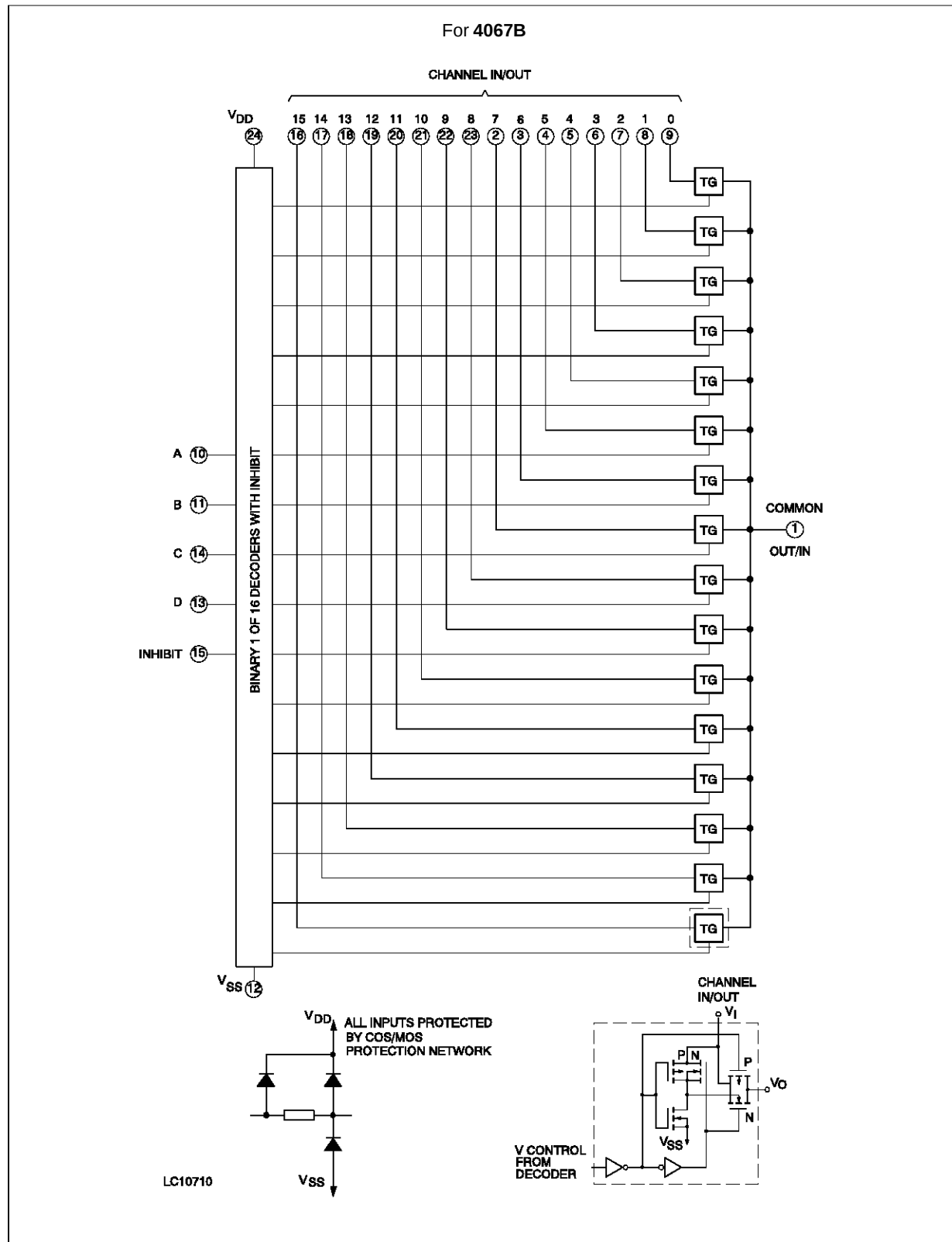
The **HCC/HCF4067B** is a 16-channel multiplexer with four binary control inputs A, B, C, D, and an inhibit input, arranged so that any combination of the inputs selects one switch.

The **HCC/HCF4097** is a differential 8-channel multiplexer having three binary control inputs A, B, C, and an inhibit input. The inputs permit selection of one

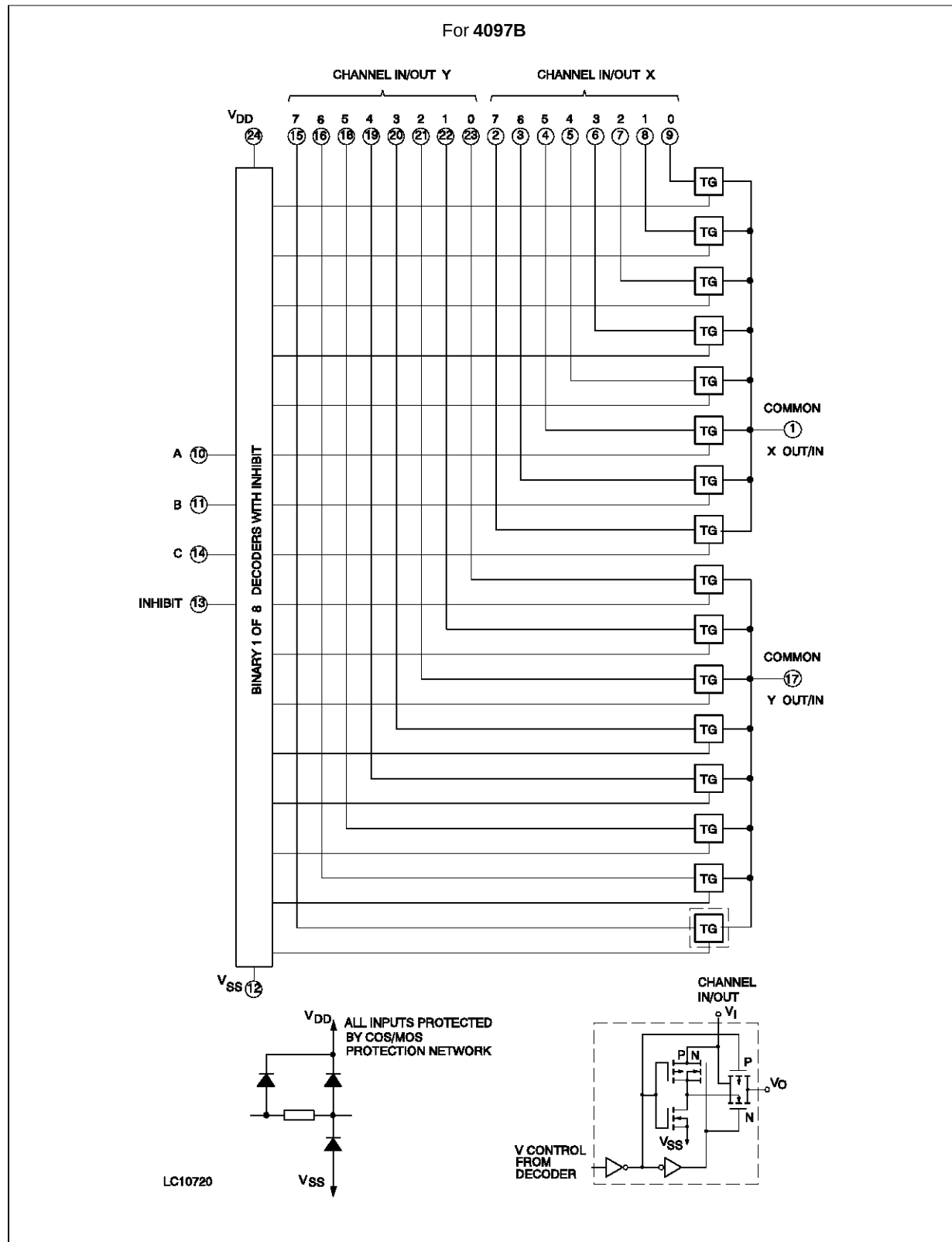
FUNCTIONAL DIAGRAM



LOGIC DIAGRAM



LOGIC DIAGRAM



TRUTH TABLES FOR HCC/HCF4067B

A	B	C	D	INH	SELECTED CHANNEL
X	X	X	X	1	None
0	0	0	0	0	0
1	0	0	0	0	1
0	1	0	0	0	2
1	1	0	0	0	3
0	0	1	0	0	4
1	0	1	0	0	5
0	1	1	0	0	6
1	1	1	0	0	7
0	0	0	1	0	8
1	0	0	1	0	9
0	1	0	1	0	10
1	1	0	1	0	11
0	0	1	1	0	12
1	0	1	1	0	13
0	1	1	1	0	14
1	1	1	1	0	15

TRUTH TABLE FOR HCC/HCF4097B

A	B	C	INH	SELECTED CHANNEL
X	X	X	1	None
0	0	0	0	0X 0Y
1	0	0	0	1X 1Y
0	1	0	0	2X 2Y
1	1	0	0	3X 3Y
0	0	1	0	4X 4Y
1	0	1	0	5X 5Y
0	1	1	0	6X 6Y
1	1	1	0	7X 7Y

ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
V_{DD}^*	Supply Voltage: HCC Types HCF Types	-0.5 to +20 -0.5 to +18	V V
V_i	Input Voltage	-0.5 to $V_{DD} + 0.5$	V
I_i	DC Input Current (any one input)	± 10	mA
P_{tot}	Total Power Dissipation (per package) Dissipation per Output Transistor for T_{op} = Full Package Temperature Range	200 100	mW mW
T_{op}	Operating Temperature: HCC Types HCF Types	-55 to +125 -40 to +85	$^{\circ}\text{C}$ $^{\circ}\text{C}$
T_{stg}	Storage Temperature	-65 to +150	$^{\circ}\text{C}$

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for external periods may affect device reliability.

* All voltage values are referred to V_{SS} pin voltage.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{DD}	Supply Voltage: HCC Types HCF Types	3 to 18 3 to 15	V V
V_i	Input Voltage	0 to V_{DD}	V
T_{op}	Operating Temperature: HCC Types HCF Types	-55 to +125 -40 to +85	$^{\circ}\text{C}$ $^{\circ}\text{C}$

STATIC ELECTRICAL CHARACTERISTICS (over recommended operating conditions)

Symbol	Parameter		Test Conditions				Value							Unit	
			V _{IS} (V)	V _{EE} (V)	V _{SS} (V)	V _{DD} (V)	T _{LOW} *		25 °C			T _{HIGH} *			
							Min.	Max.	Min.	Typ.	Max.	Min.	Max.		
I _L	Quiescent Supply Current	HCC types				5		5		0.04	5		150	μA	
						10		10		0.04	10		300		
						15		20		0.04	20		600		
						20		100		0.08	100		3000		
		HCF types				5		20		0.04	20		150		
						10		40		0.04	40		300		
						15		80		0.04	80		600		
SWITCH															
R _{ON}	On Resistance	HCC types	0 ≤ V _I ≤ V _{DD}	0	0	5		800		470	1050		1300	Ω	
						10		310		180	400		580		
						15		200		125	240		320		
		HCF types	0 ≤ V _I ≤ V _{DD}	0	0	5		850		470	1050		1200		
						10		330		180	400		520		
						15		210		125	240		300		
ΔON	Resistance ΔR _{ON} (Between any two channels)			0	0	5				10			Ω		
						10				10					
						15				5					
OFF (●) Channel Leakage Current	Any Channel OFF	HCC types		0	0	18		100		±0.1	100		1000	μA	
	All Channel OFF (common OUT/IN)	HCC types		0	0	18		100		±0.1	100		1000		
	Any Channel OFF	HCF types		0	0	15		300		±0.1	300		1000		
	All Channel OFF (common OUT/IN)	HCF types		0	0	15		300		±0.1	300		1000		
C	Capacitance Input Output for 4067 Output for 4097 Feedthrough				-5	5				5				pF	
										55					
										35					
										0.2					
CONTROL															
V _{IL}	Input Low Voltage		= V _{DD} thru 1KΩ	V _{EE} =V _{SS} R _L =1KΩ to V _{SS} I _{IS} < 2μA (on all OFF channels)	5		1.5			1.5		1.5		V	
					10		3			3		3			
					15		4			4		4			
V _{IH}	Input High Voltage				5	3.5		3.5				3.5		V	
					10	7		7				7			
					15	11		11				11			
I _{IH} I _{IL}	Input Leakage Current	HCC types			V _I = 0/18V		18		±0.1		±10 ⁻³	±0.1		±1	μA
		HCF types			V _I = 0/15V		15		±0.3		±10 ⁻³	±0.3		±1	
C _I	Input Capacitance				Any Address or Inhibit Input							5	7.5		

• Determined by minimum feasible leakage measurement for automatic testing

* T_{LOW} = -55 °C for **HCC** device; -40 °C for **HCF** device.

* T_{HIGH} = +125 °C for **HCC** device; +85 °C for **HCF** device.

The Noise Margin for both "1" and "0" level is: 1V min. with V_{DD} = 5 V, 2 V min. with V_{DD} = 10 V, 2.5 V min. with V_{DD} = 15 V

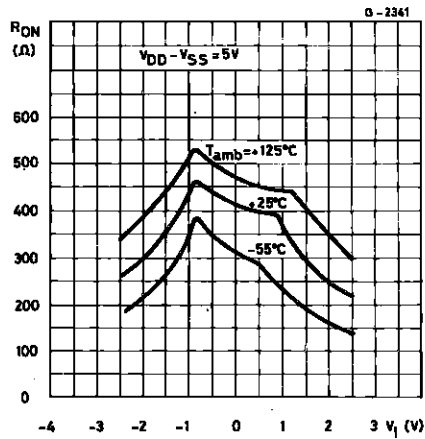
DYNAMIC ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^{\circ}\text{C}$, $C_L = 50\text{ pF}$, $R_L = 200\text{ K}\Omega$, typical temperature coefficient for all V_{DD} values is $03\text{ }^{\circ}\text{C}/^{\circ}\text{C}$, all input rise and fall times = 20 ns)

Symbol	Parameter	Test Conditions							Value		Unit
		V _C (V)	R _L (KΩ)	f _i (KHz)	V _I (V)	V _{SS} (V)	V _{DD} (V)		Typ.	Max.	
SWITCH											
t _{pd}	Propagation Delay Time (Signal Input to Output)	= V _{DD}	200		0		5		30	60	ns
							10		15	30	
							15		11	20	
	Frequency Response Channel "ON" (Sine Wave Input) at $20\text{ Log } \frac{V_O}{V_I} = -3\text{ dB}$	= V _{DD}	1		5 (●)	0	10	V _O at Common OUT/IN	4067B	14	ns
									4097B	20	
								V _O at Any Channel		60	
	Feedthrough (All Channels OFF) at $20\text{ Log } \frac{V_O}{V_I} = -40\text{ dB}$	= V _{SS}	1		5 (●)	0	10	V _O at Common OUT/IN	4067B	20	MHz
									4097B	12	
								V _O at Any Channel		8	
	Frequency Signal Crosstalk at $20\text{Log } \frac{V_{\alpha(B)}}{V_{I(A)}} = -40\text{dB}$	V _{C(A)} =V _{DD} V _{C(B)} =V _{SS}	1		5 (●)	0	10	Between Any two (A and B) Channels		1	MHz
								Between Sections (A and B) 4097B only	Measured on common	10	
									Measured on Any Channel	18	
t _w	Sine Wave Distortion (f _{is} = 1KHz sine wave)	5	10	1	2 (●)	0	5		0.3	%	
		10	10	1	3 (●)	0	10		0.2		
		15	10	1	5 (●)	0	15		0.12		
CONTROL (address or Inhibit)											
t _{PLH} t _{PHL}	Propagation Delay Time: Address or Inhibit to Signal OUT (Channel Turning ON)		1				0	5	325	650	ns
							0	10	135	270	
							0	15	95	190	
t _{PLH} t _{PHL}	Propagation Delay Time: Address or Inhibit to Signal OUT (Channel Turning OFF)		0.3				0	5	220	440	ns
							0	10	90	180	
							0	15	65	130	
	Address or Inhibit to Signal Crosstalk		10*				0	10	75		mV peak

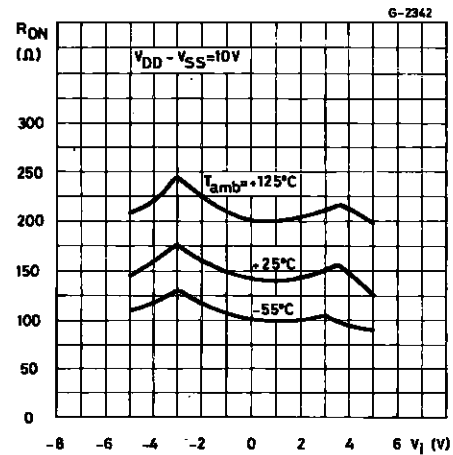
(●) Peak to peak voltage symmetrical about $\frac{V_{DD} - V_{SS}}{2}$

(*) Both ends of channel

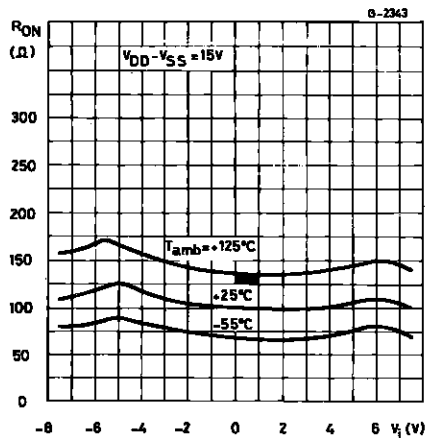
Typical ON Resistance vs Input Signal Voltage
(All Types)



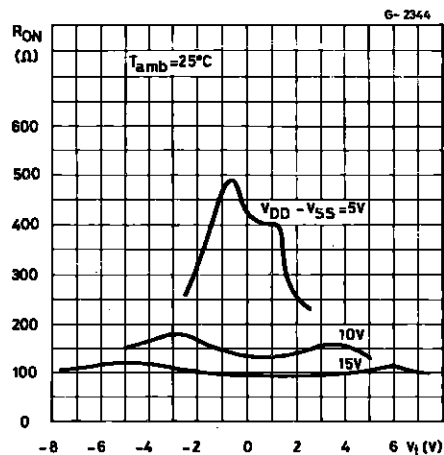
Typical ON Resistance vs Input Signal Voltage
(All Types)



Typical ON Resistance vs Input Signal Voltage
(All Types)

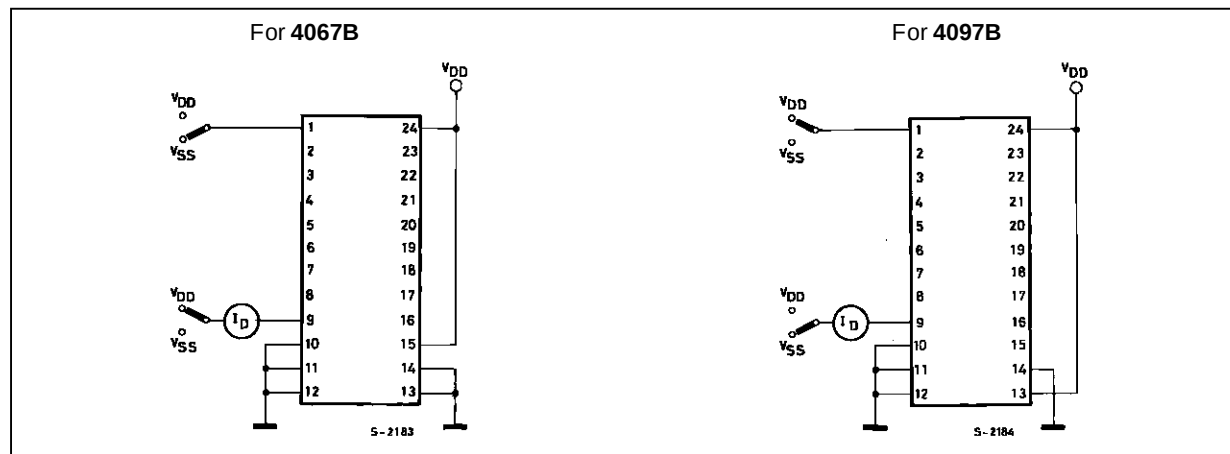


Typical ON Resistance vs Input Signal Voltage
(All Types)

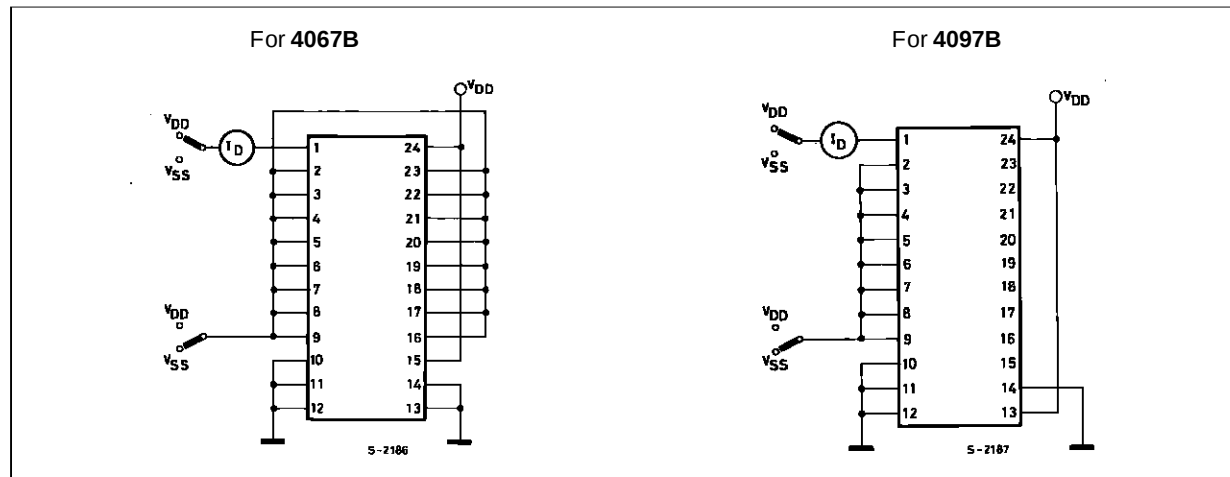


TEST CIRCUITS

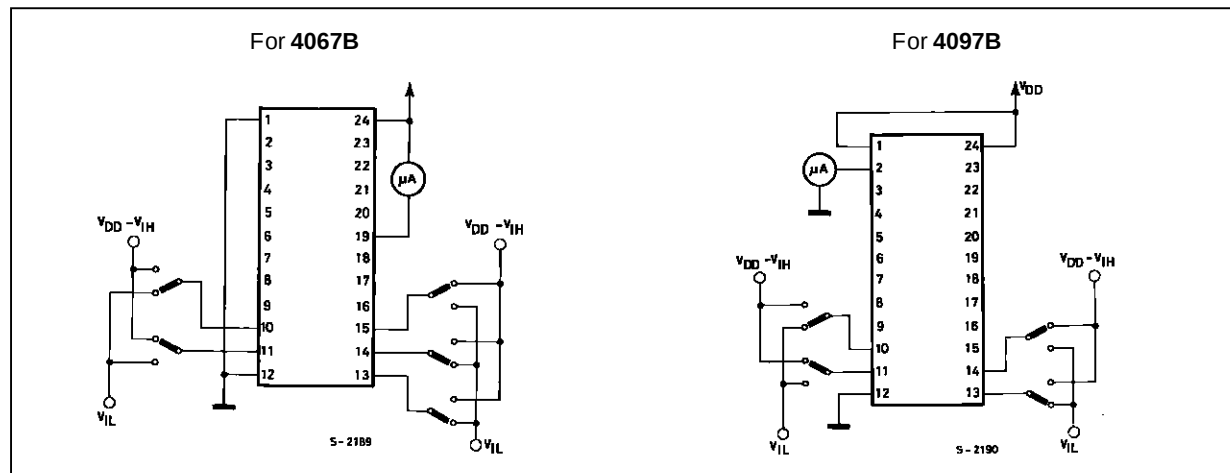
OFF Channel Leakage Current Any Channel OFF



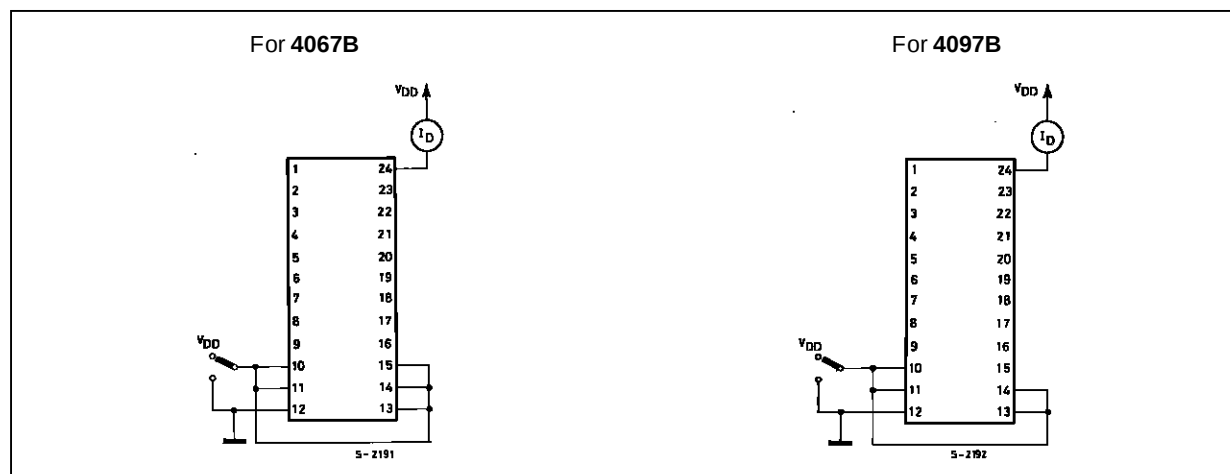
OFF Channel Leakage Current All Channels OFF



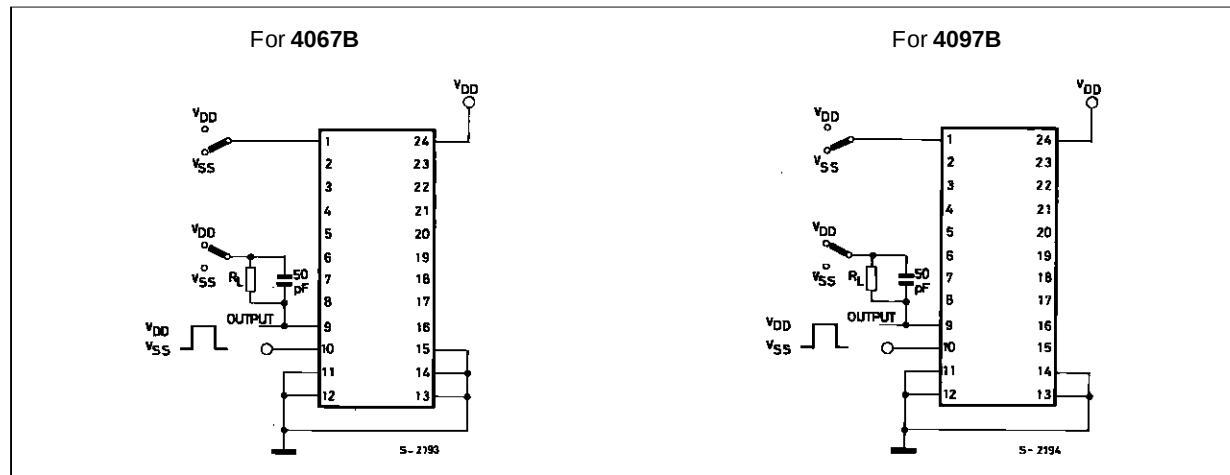
Input Voltage Measure < 2 μ A an All OFF Channels (e.g. Channel 12)



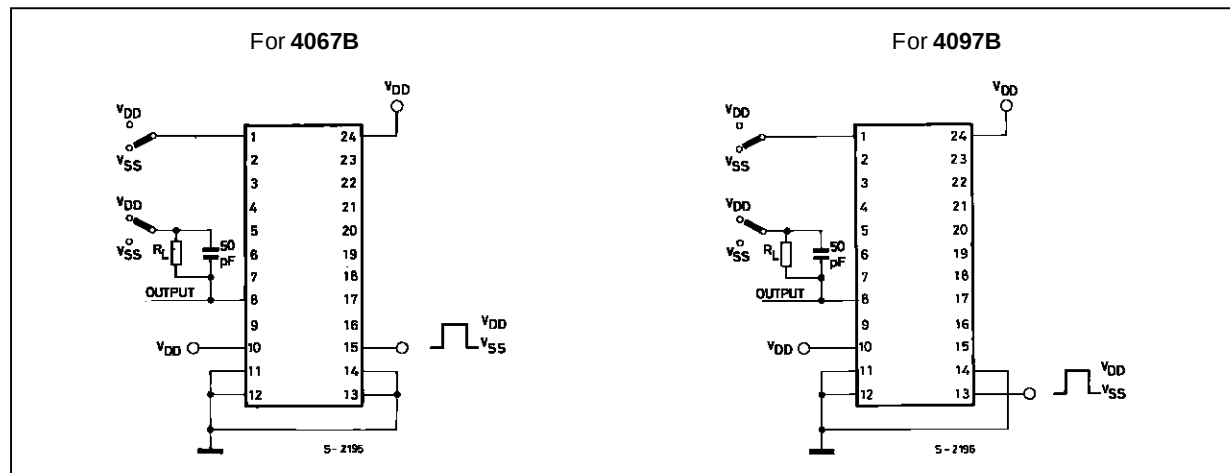
Quiescent Device Current



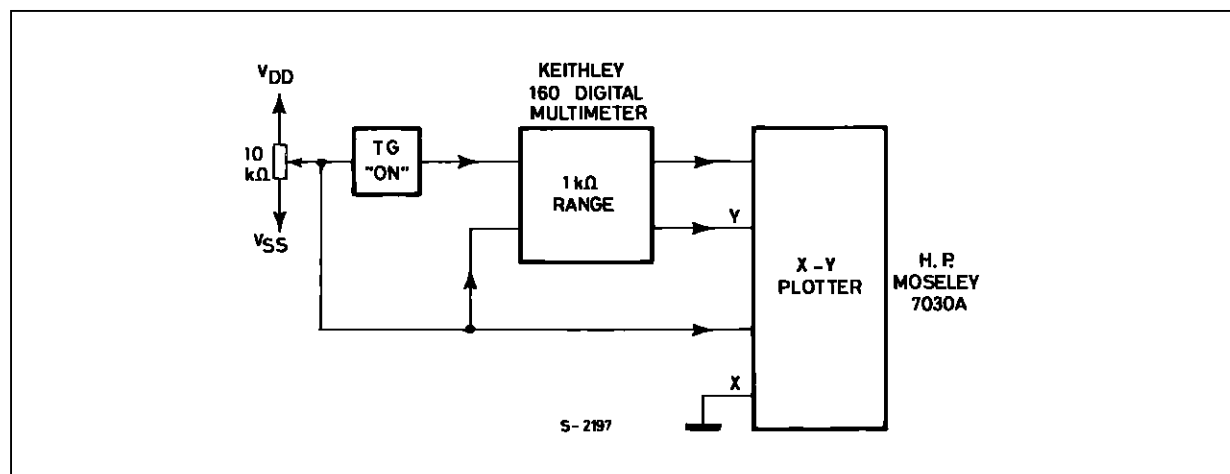
Turn-on and Turn-off Propagation Delay Address Select Input to Signal Output (e. g. Channel 0)



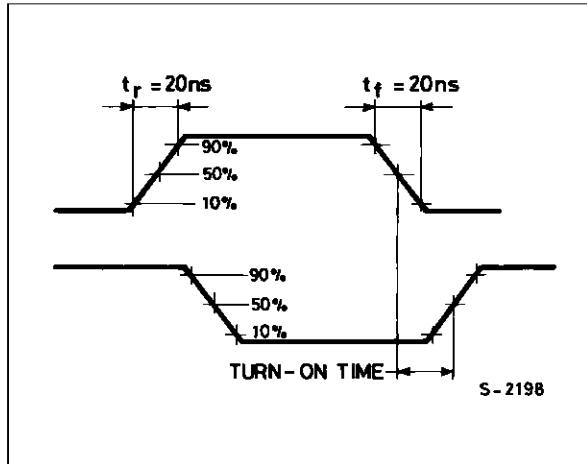
Turn-on and Turn-off Propagation Delay-Inhibit Input to Signal Output (e. g. Channel 1)



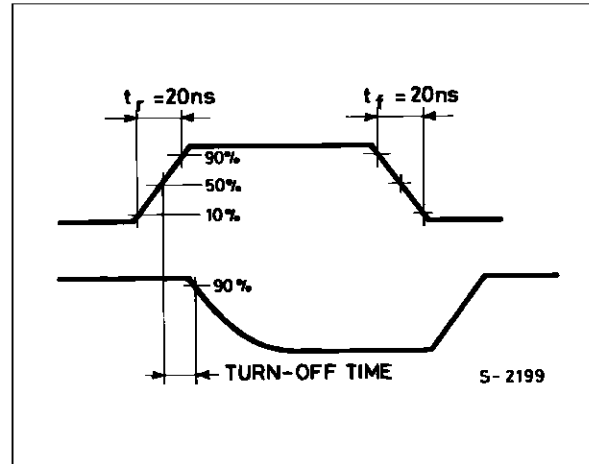
Channel ON Resistance Measurement Circuit



Propagation Delay Waveform Channel Being Turned ON ($R_L = 10\text{ K}\Omega$, $C_L = 50\text{ pF}$)



Propagation Delay Waveform Channel Being Turned OFF ($R_L = 300\text{ }\Omega$, $C_L = 50\text{ pF}$)



APPLICATIONS INFORMATION

In applications where separate power sources are used to drive V_{DD} and the signal inputs, the V_{DD} current capability should exceed V_{DD}/R_L (R_L = effective external load). This provision avoids permanent current flow or clamp action on the V_{DD} supply when power is applied or removed from the **HCC/HCF4067B** or **HCC/HCF4097B**.

When switching from one address to another, some of the ON periods of the channels of the multiplexers will overlap momentarily, which may be objectionable in certain applications. Also when a channel is turned ON or OFF by an address input, there is a momentary conductive path from the channel to V_{SS} , which will dump some charge from any capacitor connected to the input or output of the channel. The inhibit input turning on a channel will similarly dump some charge to V_{SS} .

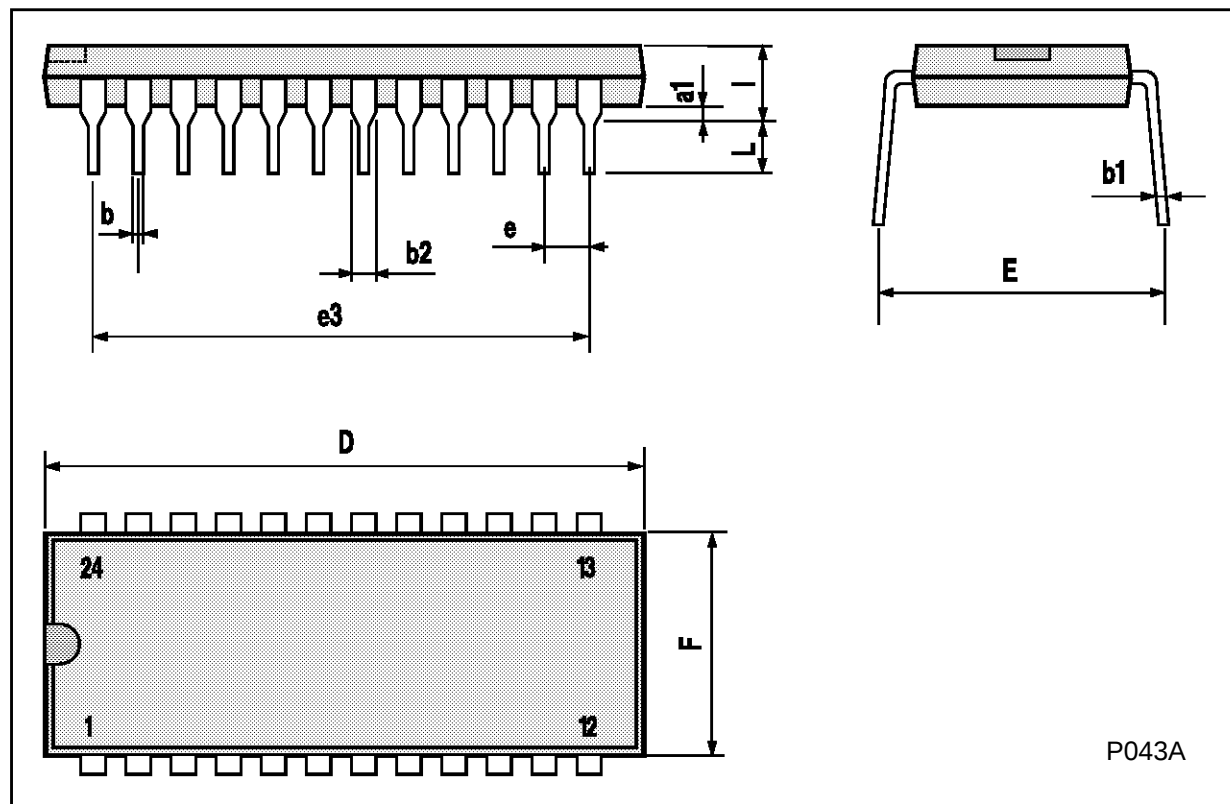
The amount of charge dumped is mostly a function of the signal level above V_{SS} . Typically, at $V_{DD} - V_{SS} = 10\text{V}$, a 100 pF capacitor connected to the input or output of the channel will

lose 3-4% of its voltage at the moment the channel turns ON or OFF. This loss of voltage is essentially independent of the address or inhibit signal transition time, if the transition time is less than 1-2 μs . When the inhibit signal turns a channel off, there is no charge dumping of V_{SS} . Rather, there is a slight rise in the channel voltage level (65 mV typ.) due to the capacitance coupling from inhibit input to channel input or output. Address input also couples some voltage steps onto the channel signal levels.

In certain applications, the external load-resistor current may include both V_{DD} and signal line components. To avoid drawing V_{DD} current when switch current flows into the transmission gate inputs, the voltage drop across the bidirectional switch must not exceed 0.8 V (calculated from R_{ON} values shown in ELECTRICAL CHARACTERISTICS CHART). No V_{DD} current will flow through R_L if the switch current flows into terminal 1 on the **HCC/HCF4067B**, terminals 1 and 17 on the **HCC/HCF4097B**.

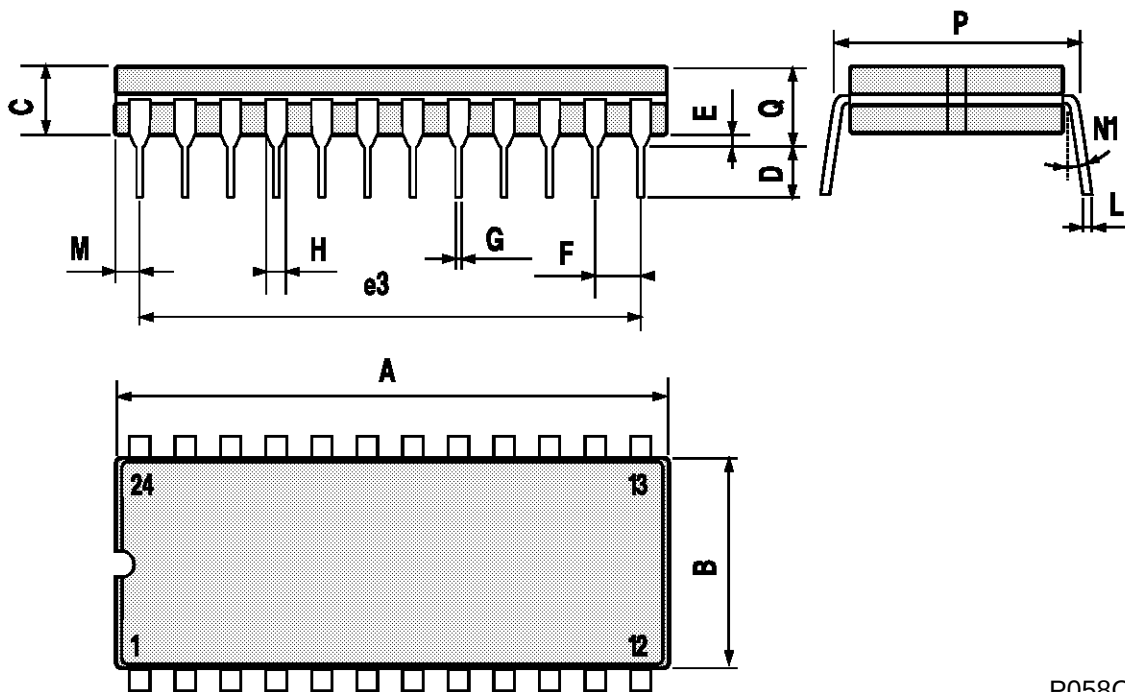
Plastic DIP24 (0.25) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1		0.63			0.025	
b		0.45			0.018	
b1	0.23		0.31	0.009		0.012
b2		1.27			0.050	
D			32.2			1.268
E	15.2		16.68	0.598		0.657
e		2.54			0.100	
e3		27.94			1.100	
F			14.1			0.555
l		4.445			0.175	
L		3.3			0.130	



Ceramic DIP24 MECHANICAL DATA

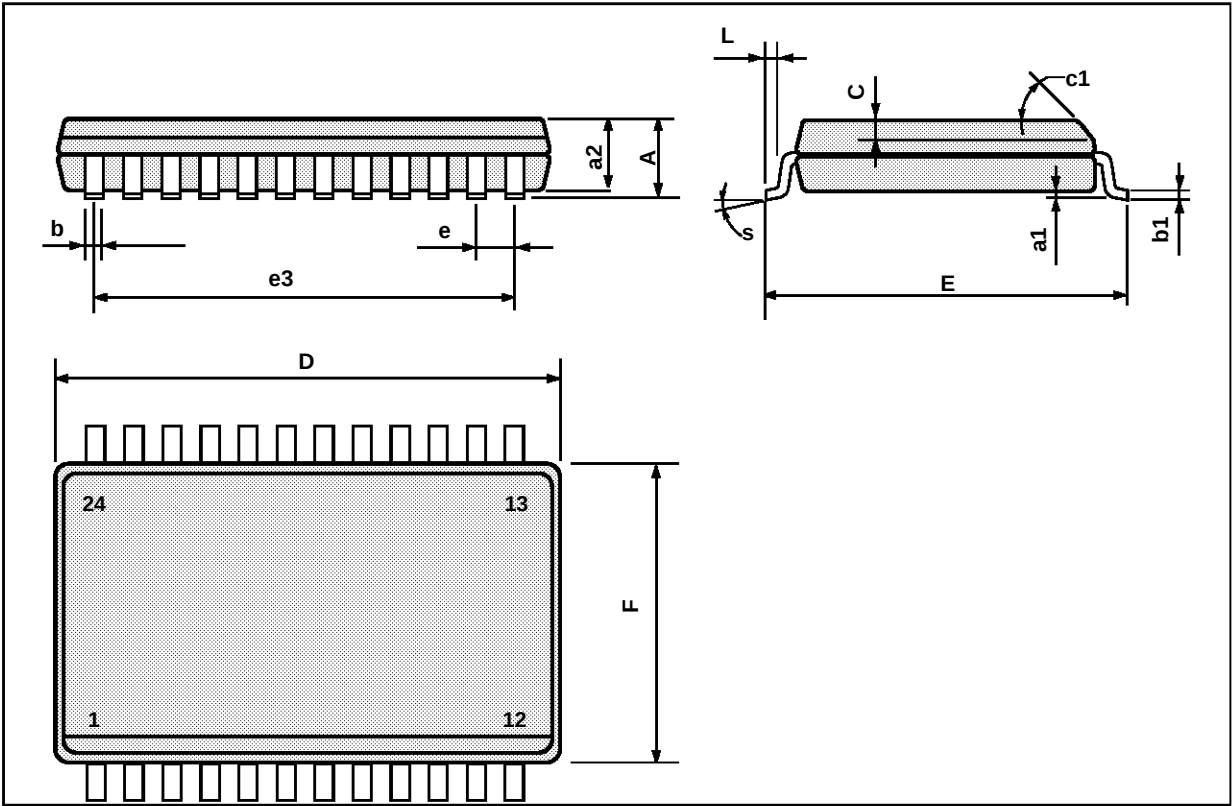
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			32.3			1.272
B	13.05		13.36	0.514		0.526
C	3.9		5.08	0.154		0.200
D	3			0.118		
E	0.5		1.78	0.020		0.070
e3		27.94			1.100	
F	2.29		2.79	0.090		0.110
G	0.4		0.55	0.016		0.022
I	1.17		1.52	0.046		0.060
L	0.22		0.31	0.009		0.012
M	1.52		2.49	0.060		0.098
N1	4° (min.), 15° (max.)					
P	15.4		15.8	0.606		0.622
Q			5.71			0.225



P058C

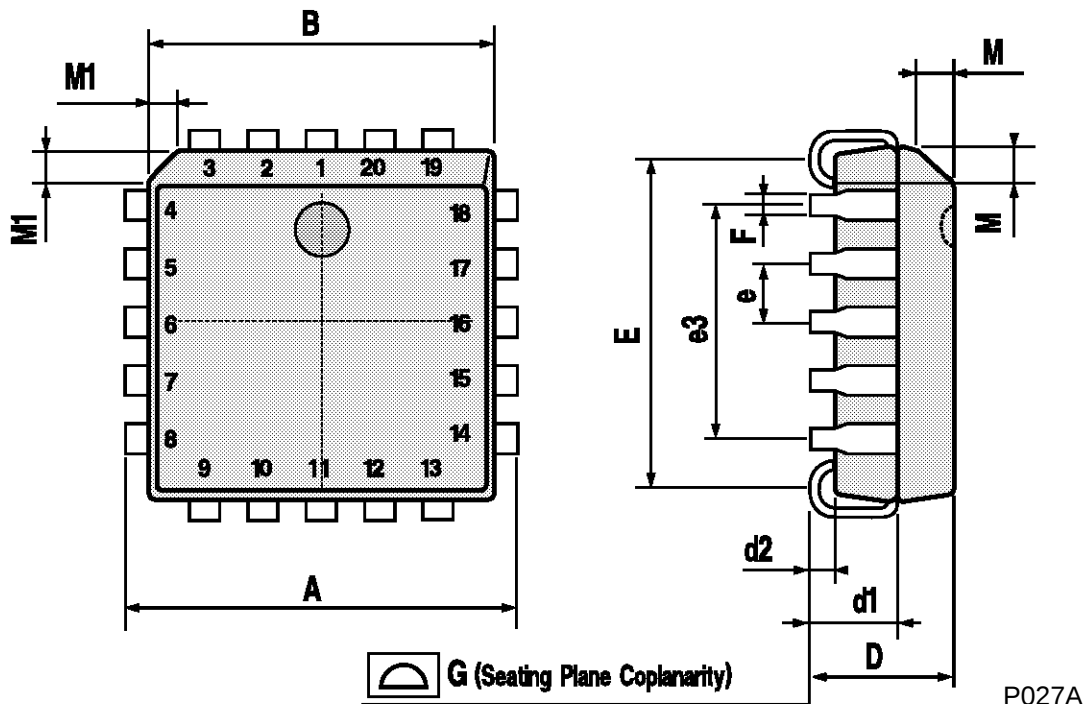
SO24 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			2.65			0.104
a1	0.10		0.20	0.004		0.007
a2			2.45			0.096
b	0.35		0.49	0.013		0.019
b1	0.23		0.32	0.009		0.012
C		0.50			0.020	
c1	45° (typ.)					
D	15.20		15.60	0.598		0.614
E	10.00		10.65	0.393		0.420
e		1.27			0.05	
e3		13.97			0.55	
F	7.40		7.60	0.291		0.299
L	0.50		1.27	0.19		0.050
S	8° (max.)					



PLCC20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	9.78		10.03	0.385		0.395
B	8.89		9.04	0.350		0.356
D	4.2		4.57	0.165		0.180
d1		2.54			0.100	
d2		0.56			0.022	
E	7.37		8.38	0.290		0.330
e		1.27			0.050	
e3		5.08			0.200	
F		0.38			0.015	
G			0.101			0.004
M		1.27			0.050	
M1		1.14			0.045	



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